

9/19/07

Sheet 1 of 1

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12406-147US1	Application No. 10/567,883
	Applicant Wilhelm Stein et al.		
	Filing Date August 14, 2006	Group Art Unit 2811	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/FYL/	AL	WO 01/41225	6/7/2001	WIPO				
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature /Feifei Yeung Lopez/ (12/10/2007)	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Disclosure Form (PTO-1449)

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		Applicant Wilhelm Stein et al.	10/567883
		Filing Date Herewith	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/FYL/	AA	5,115,286	05/19/1992	Camras et al.			
↓	AB	5,889,295	03/30/1999	Rennie et al.			
	AC	5,861,636	01/19/1999	Dutta et al.			
	AD	6,403,987	06/11/2002	Miki et al.			
	AE	2002/0074558	06/20/2002	Hata et al.			
	AF	6,420,732	07/16/2002	Kung et al.			
	AG	2002/0096687	07/25/2002	Kuo et al.			
	AH	2002/0137244	09/26/2002	Chen et al.			
↓	AI	6,878,563	04/12/2005	Bader et al.			
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	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/FYL/	AL	DE 19820777	11/12/1998	Germany			Equivalent to US 6,403,987	
↓	AM	DE 10020464	11/08/2001	Germany			Equivalent to US 6,878,563	
	AN	EP 1 271665	01/02/2003	Europe				
↓	AO	JP 2000-353820	12/19/2000	Japan			Abstract	
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
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